

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/663,859 | Applicant(s)/Patent Under Reexamination BYUN, KYUNG-SEOK | |
| | Examiner Justin Krause | Art Unit 3682 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| * | A | US-5,950,495 | 09-1999 | Ogawa et al. | 74/490.01 |
| * | B | US-RE37,731 | 06-2002 | Ogawa et al. | 74/490.01 |
| * | C | US-2001/0004852 | 06-2001 | Mitsuyoshi, Toshihiko | 74/490.01 |
| * | D | US-5,857,826 | 01-1999 | Sato et al. | 414/744.6 |
| * | E | US-5,775,169 | 07-1998 | Solomon et al. | 74/490.01 |
| * | F | US-5,180,276 | 01-1993 | Hendrickson, Ruth A. | 414/752.1 |
| * | G | US-6,057,662 | 05-2000 | McAndrew et al. | 318/567 |
| * | H | US-5,421,695 | 06-1995 | Kimura, Masayuki | 414/744.5 |
| * | I | US-6,299,404 | 10-2001 | Muka et al. | 414/744.5 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.